


<b>Search Notes</b>  	<b>Application/Control No.</b>  10591707	<b>Applicant(s)/Patent Under Reexamination</b>  MIYOSHI, KENICHI
	<b>Examiner</b>  Nguyen, Hai V	<b>Art Unit</b>  2618

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	11.1	02/17/2008	HN

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (see search history printout report)	02/17/2008	HN
Google search: OFDM TDD FDD relay mobile	01/17/2008	HN

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>